

FIG. 1. He specular-beam intensity, I, vs CO exposure at constant pressure ( $p_{\text{CO}} \simeq 3 \times 10^{-9}$  mbar) and constant temperature. The He beam is scattered from an "ideal" Pt(111) surface at 293 K (crosses) and from a Pt(111) surface with defects at 293 K (open squares) and 107 K (filled circles).  $I_0$  is the He intensity from the corresponding clean surface at the temperature of the respective adsorption experiment.

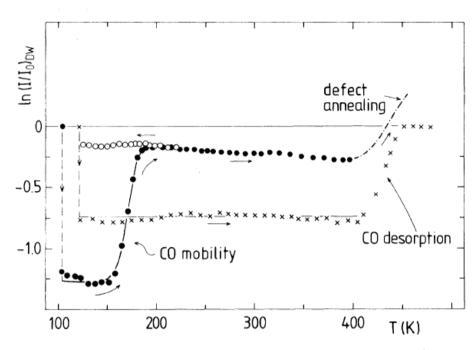
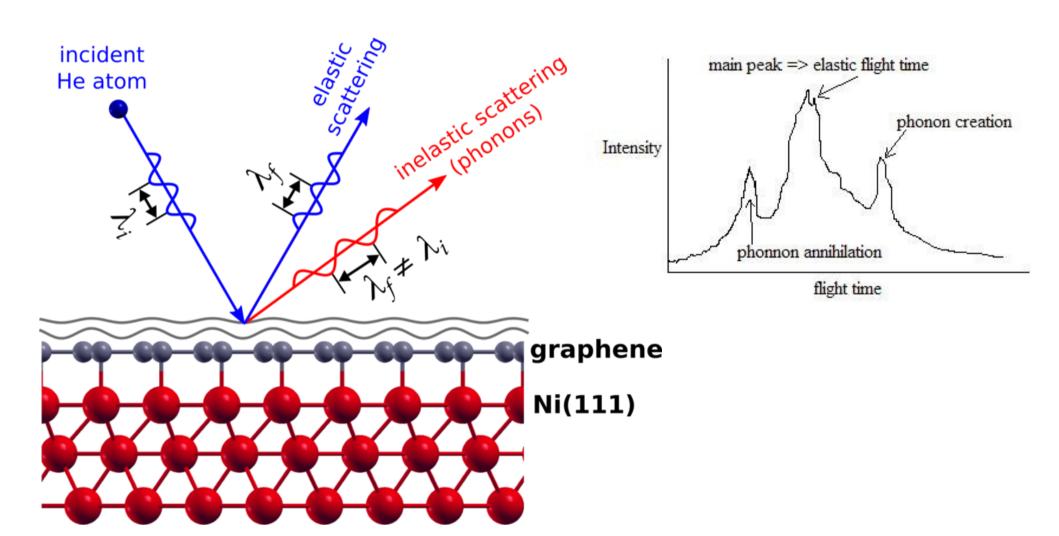


FIG. 2. Relative He specular-beam intensity  $(I/I_0)$  vs surface temperature. The He beam is scattered from a Pt(111) surface with defects (filled circles for heating and empty circles for cooling) and from an "ideal" Pt(111) surface (crosses) which were initially CO covered at low temperatures (coverage 2.5% and 1.5%, respectively).  $I_0$  is the He intensity scattered from the corresponding clean surface. The ratio of the  $I_0$  values for the "ideal" surface and the surface with defects is about 5. The data are corrected for Debye-Waller effects (see text).



## XRD

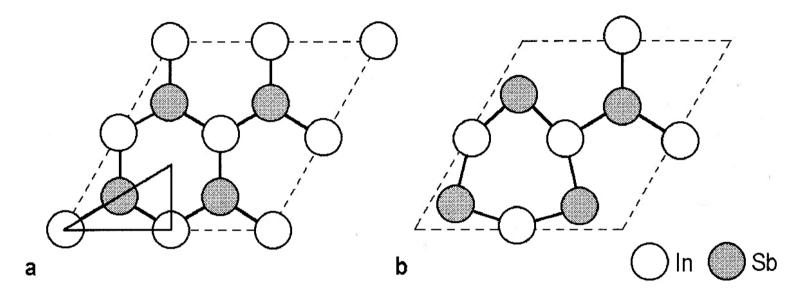


Fig. 4.19. The projection of atomic positions within a  $(2\times2)$  unit cell in (a) the ideal bulk-like terminated InSb(111) surface and (b) the reconstructed InSb(111)2×2 surface structure as determined using GIXRD analysis. The triangle shown in bold lines in (a) is the smallest symmetrically inequivalent unit after taking into account the symmetry of the substrate and the inversion imposed in x-ray diffraction data (after Feidenhans'l [4.8])

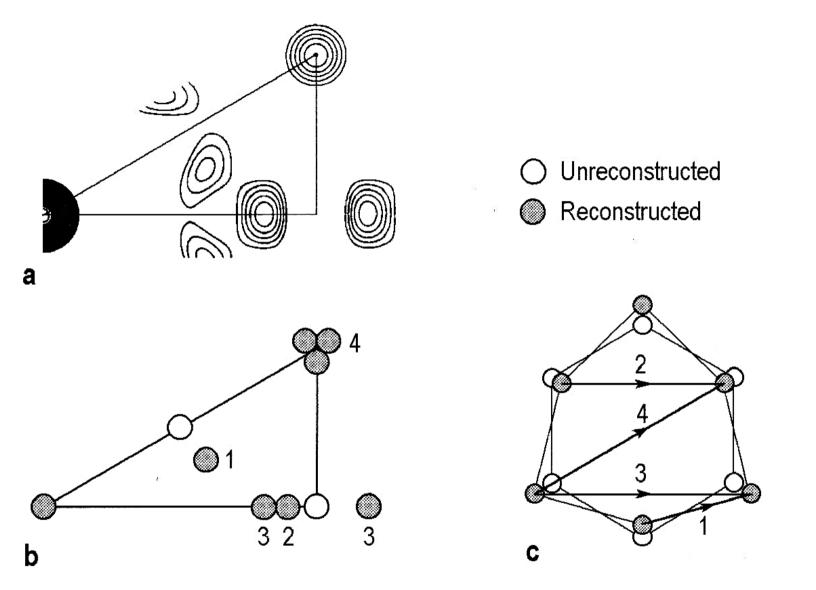
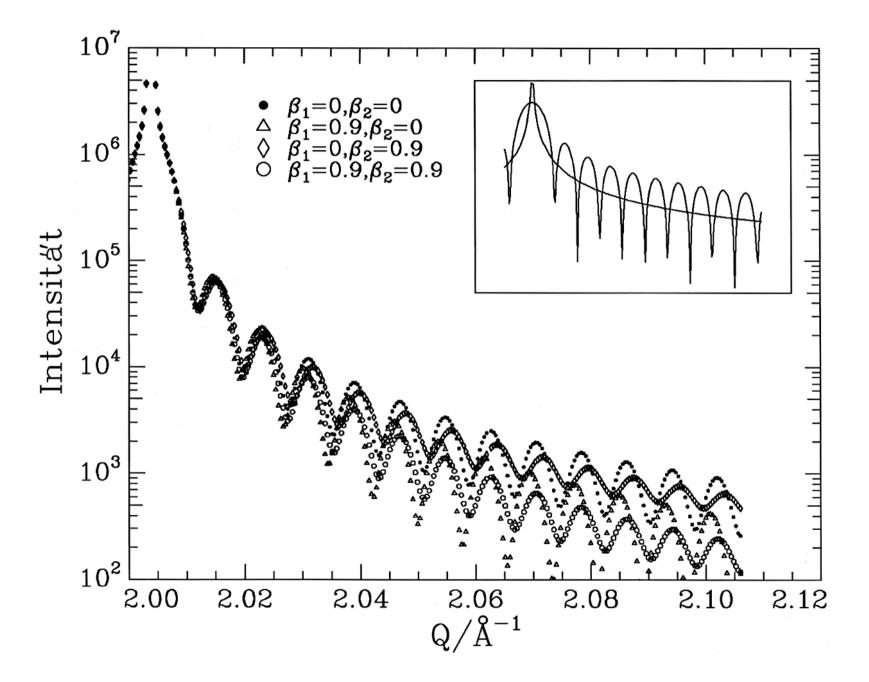
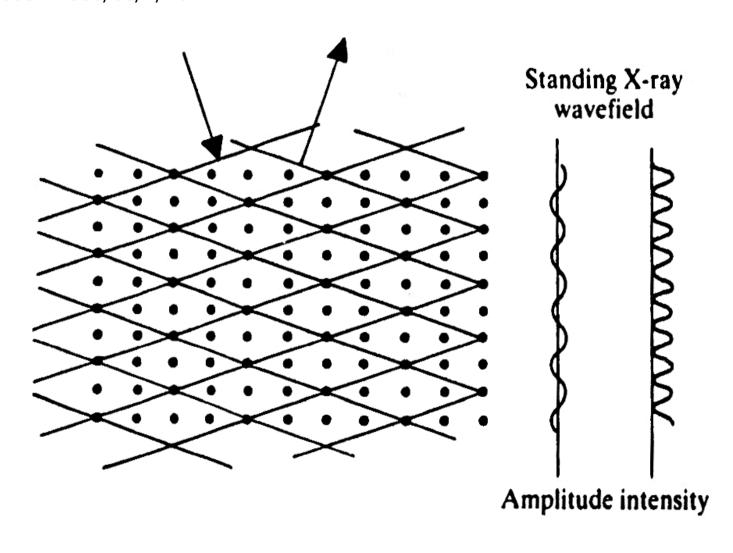


Fig. 4.20. (a) Contour map of the Patterson function for the InSb(111) surface within the unit triangle shown in Fig. 4.19a. (b) Interatomic vectors as derived from vectors 1 to 4 in (a). (c) Undistorted and distorted hexagonal arrangement of atoms producing the peaks in (b) (after Feidenhans'l [4.8])

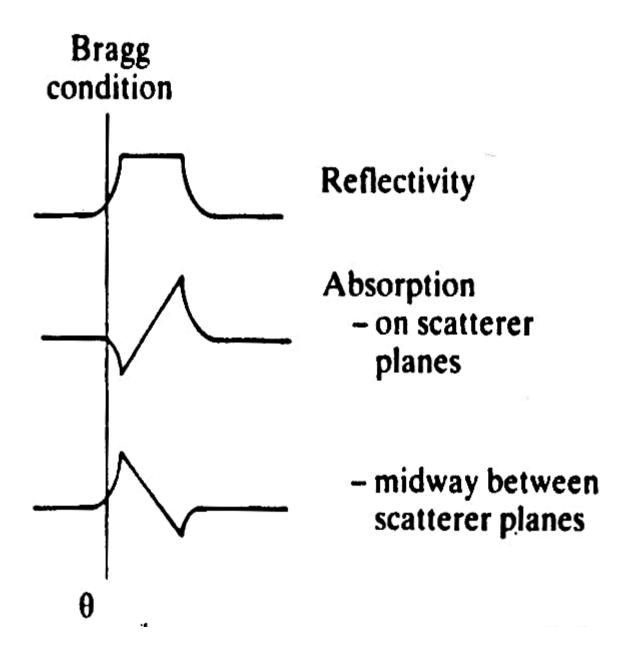


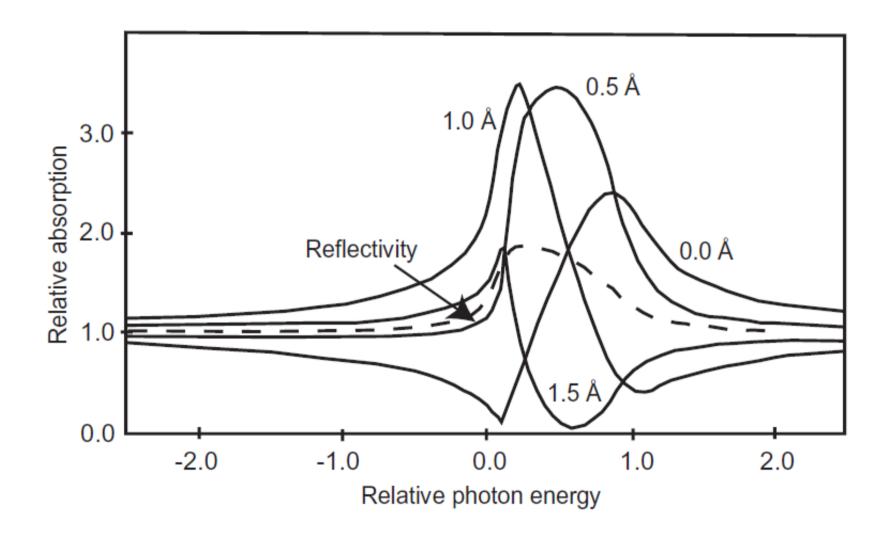
## X-ray standing waves (XSW)

D P Woodruff, Rep. Prog. Phys. **68** (2005) 743 Surface structure determination using XSW doi:10.1088/0034-4885/68/4/R01

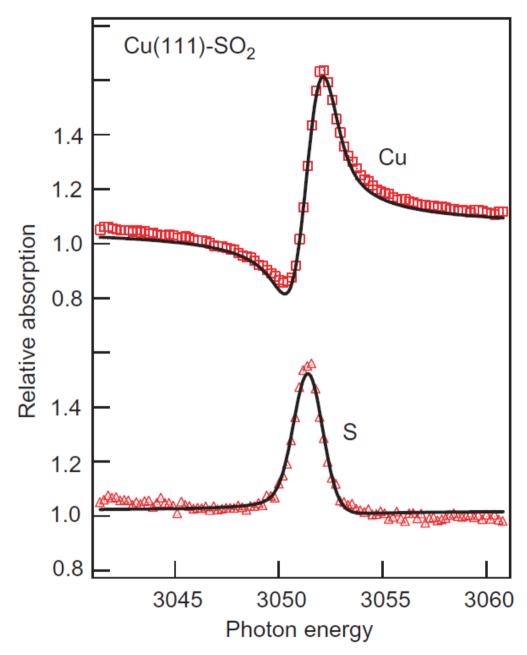


Messung der Absorption via Photo- oder Augerelektronen





Relative absorption profiles expected for an absorber atom placed in different positions relative to the (111) scatterer planes in Cu. No instrumental energy broadening is included.



Expt'l absorption profiles of  $SO_2$  on Cu(111) measured in (111) NIXSW. Lines are theoretical fits: Cu substrate corresponds to 0 spacing relative to the Cu scattering planes. S corresponds to 2.74 Å spacing (= 0.66Å + 1 substrate layer spacing of 2.08 Å).